

On-Chip Passive Elements Using MEMS

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Agenda

- Overview
- Evolution of MEMS
- Realization of passive elements
 - Inductors
 - Capacitors
- Process Dependence
- Conclusions & Challenges

Overview

“There’s plenty of room at the bottom...” Richard Feynman

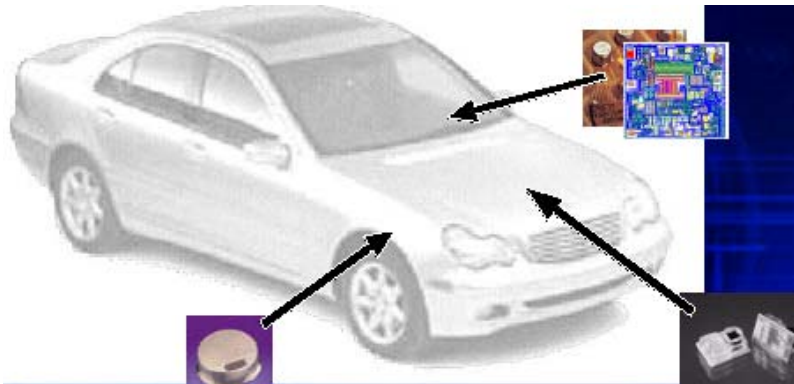
- MEMS
Micro Electro Mechanical Systems
 - Very fertile technology
 - Systems obtained by **micro fabrication**
- **Micro fabrication** is the micromachining process which is done by adding layers or etching away some parts of the wafer to have electromechanical devices

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Evolution of MEMS

- From traditional ..



Airbag Deployment
MEMS accelerometer

MEMS Pressure Sensor

Stability Control System
MEMS micro-gyro

Evolution of MEMS (contd..)

- ..to potential



Antennas

Color bi-stable display

Micro-switches

Tunable Passives

Tunable Filters

Directional microphone

**On-chip Inductors
& Capacitors**

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Realization of Passive Elements - Inductors

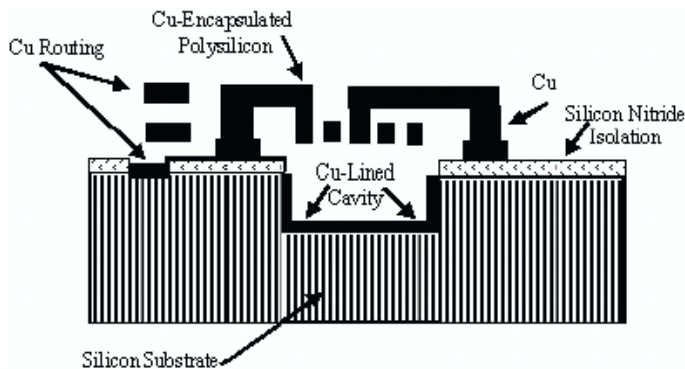
- Integrated Passive Inductors
 - Low Q Factor
 - High Occupied Surface
 - Cumbersome Packaging
- Micromachined Inductors
 - Improved performance
 - High Q factor
 - Reduced Capacitive effects
 - Integration : light, small volume

Realization of Passive Elements – Inductors (contd..)

1. Under etched Inductors ¹

Remove the substrate under the inductor spiral

- Deep cavity
- Metallization



$$Q = 30$$

$$F_{\text{res}} = 10.7 \text{ GHz}$$

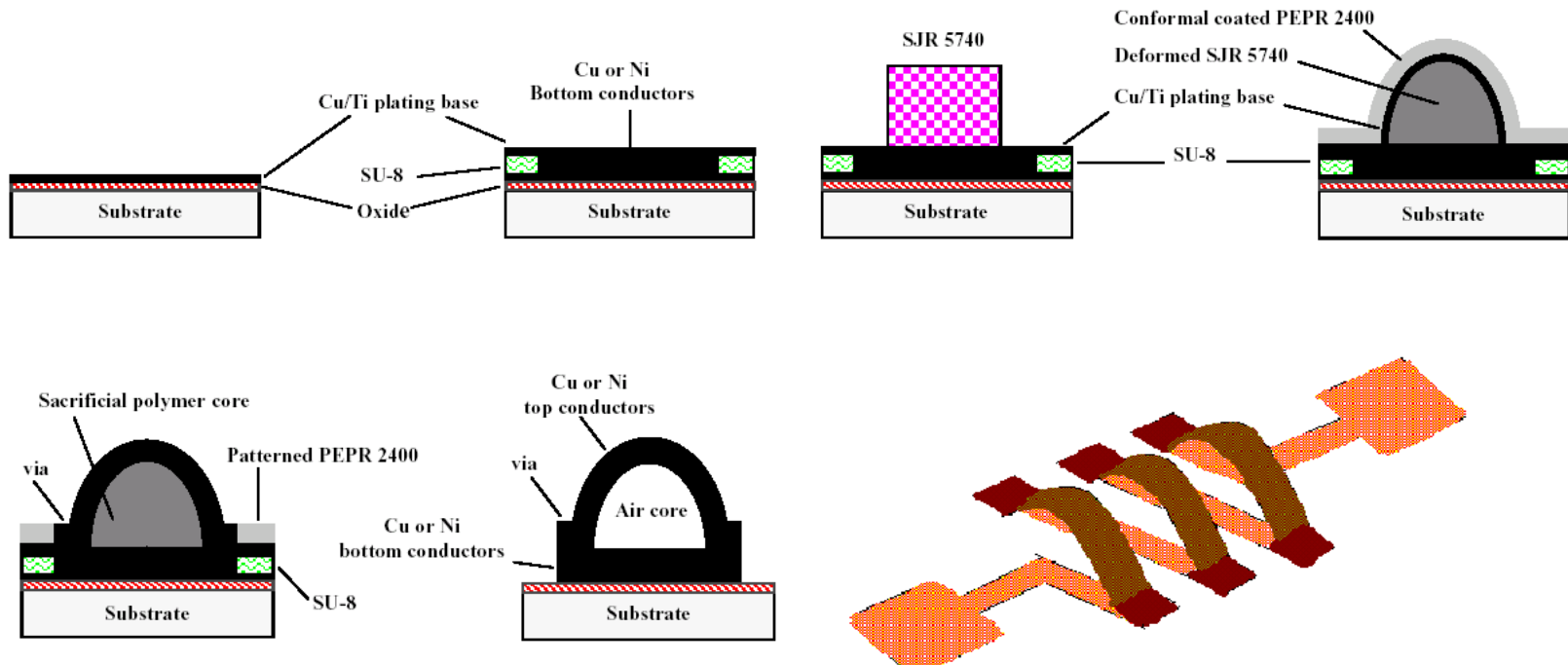
$$L = 10 \text{ nH (7 turns)}$$

1. Si_3N_4 – isolation
2. Etching - RIE
3. Sacrificial Block formed
4. CMP
5. Patterning of Inductor
6. RTA
7. Released in HF
8. Electroless Cu deposition

Realization of Passive Elements – Inductors (contd..)

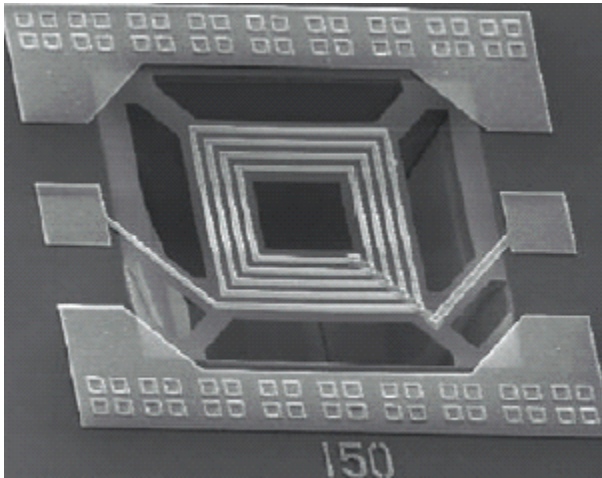
2. 3-D Solenoid Inductors ²

Higher $Q = 60$, $F_{\text{res}} < 15\text{GHz}$

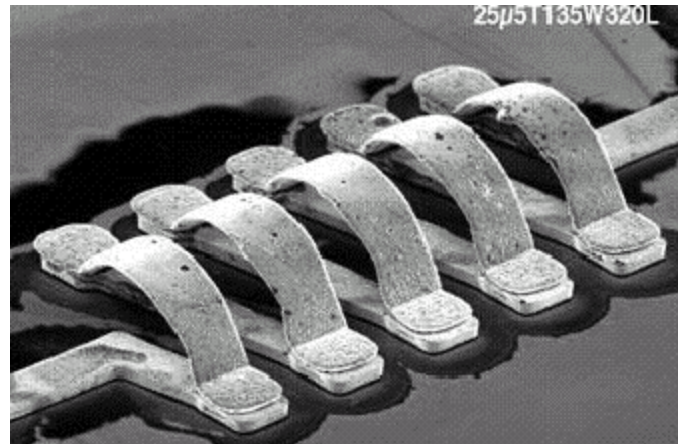


Realization of Passive Elements

– Inductors (contd..)



Under Etched Inductor



3-D Solenoid Inductor

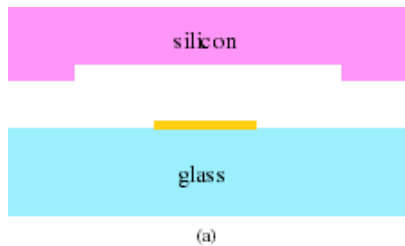
Realization of Passive Elements

– Capacitors

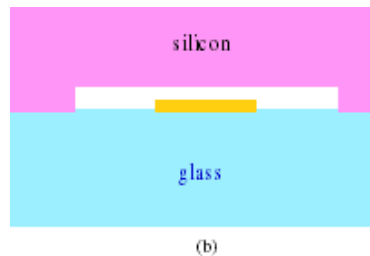
- Metal Oxide Semiconductor Capacitor
 - Large Area
 - Losses – Lower Q, Tuning Range limited
 - High process dependence
- Micromachined Capacitors
 - Improvement in Q
 - Voltage Controlled – VCO, Resonators, Filters
 - Wider Tuning Range

Realization of Passive Elements – Capacitors (contd..)

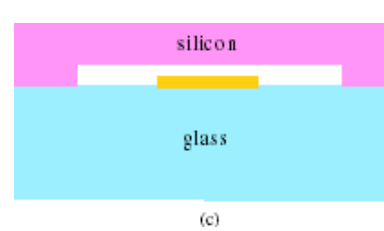
1. Linearly Tunable MEMS Capacitor ³



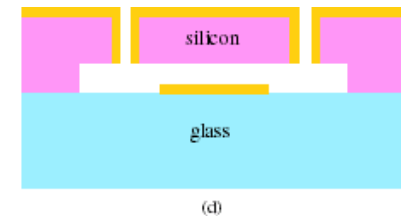
Etching of Silicon and Gold patterning



Bonding

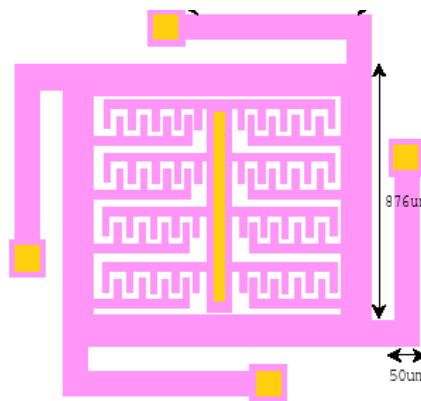


CMP



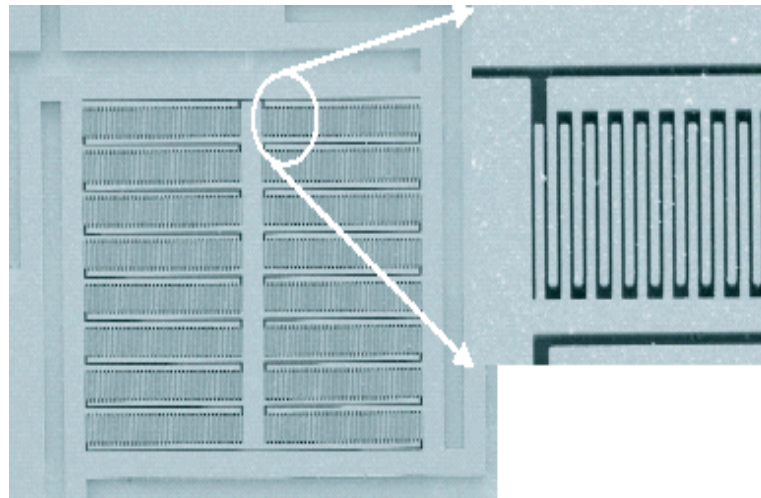
ICP etching-Au evaporation

$C = 2\text{pF}$
 $Q = 6$
 $F_{\text{res}} = 10\text{GHz}$
Tuning Range 10%@ 8V



Top View

Realization of Passive Elements – Capacitors (contd..)



SEM Picture of the MEMS Capacitor

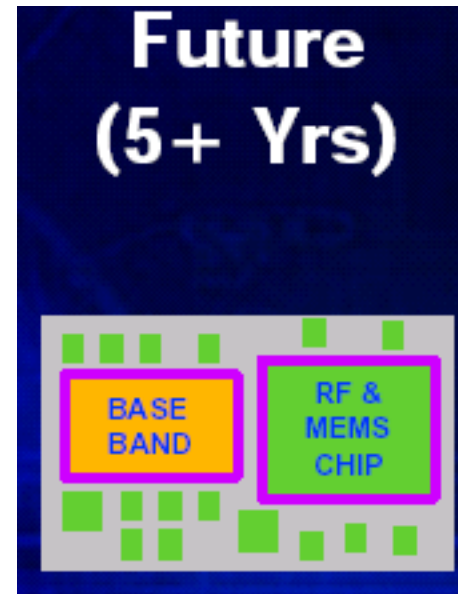
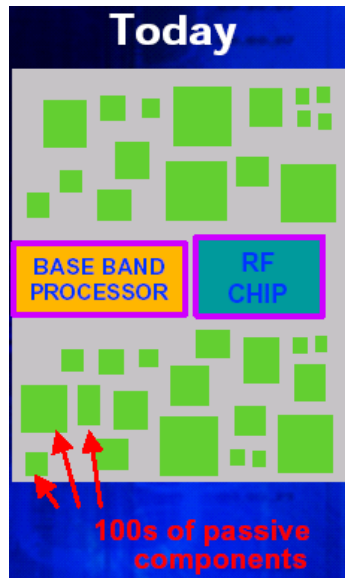
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Process Dependence

- Performance affected by:
 - Stiction - *adhesion*
 - Etch Variations – *over-etch, under-etch*
 - Particulate Contaminations
 - Curvature

Conclusions & Challenges



- Compatibility of the MEMS process with active circuitry processing is critical for the realization of integrated MEMS

THANK YOU